

Features

- Performs ASK (amplitude shift keyed) modulation and demodulation
- 32 kHz carrier frequency
- Up to 2 kbit/s full duplex data transfer rate
- On-chip oscillator
- On-chip tone caller for alerting functions
- Adjustable tone caller frequencies
- Selectable self-loop test mode
- 5V/2.5mA power supply
- ISO²-CMOS and switched capacitor technologies
- 18 Pin DIP

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Ordering Information

MT8840AE	18 Pin Plastic DIP
MT8840AS	18 Pin SOIC
0°C to +85°C	

Description

The MT8840 is a carrier over voice modem which allows simultaneous transfer of voice and data over a single pair of wires. Data is transferred on an amplitude shift keyed (ASK) 32 kHz carrier. On-chip filters remove voice frequency signals from the received composite voice and data signal prior to demodulation. The modulating signal is a bit stream with a typical data rate of 2 kbit/s. In addition, the device contains a two tone warbler which functions as a telephone ringer. The device is fabricated in MITEL's double-poly ISO²-CMOS technology utilizing switched-capacitor techniques.

Applications

- Simultaneous data and voice communication in PABXs
- 2 kbit/s data modem
- "Smart" telephone sets

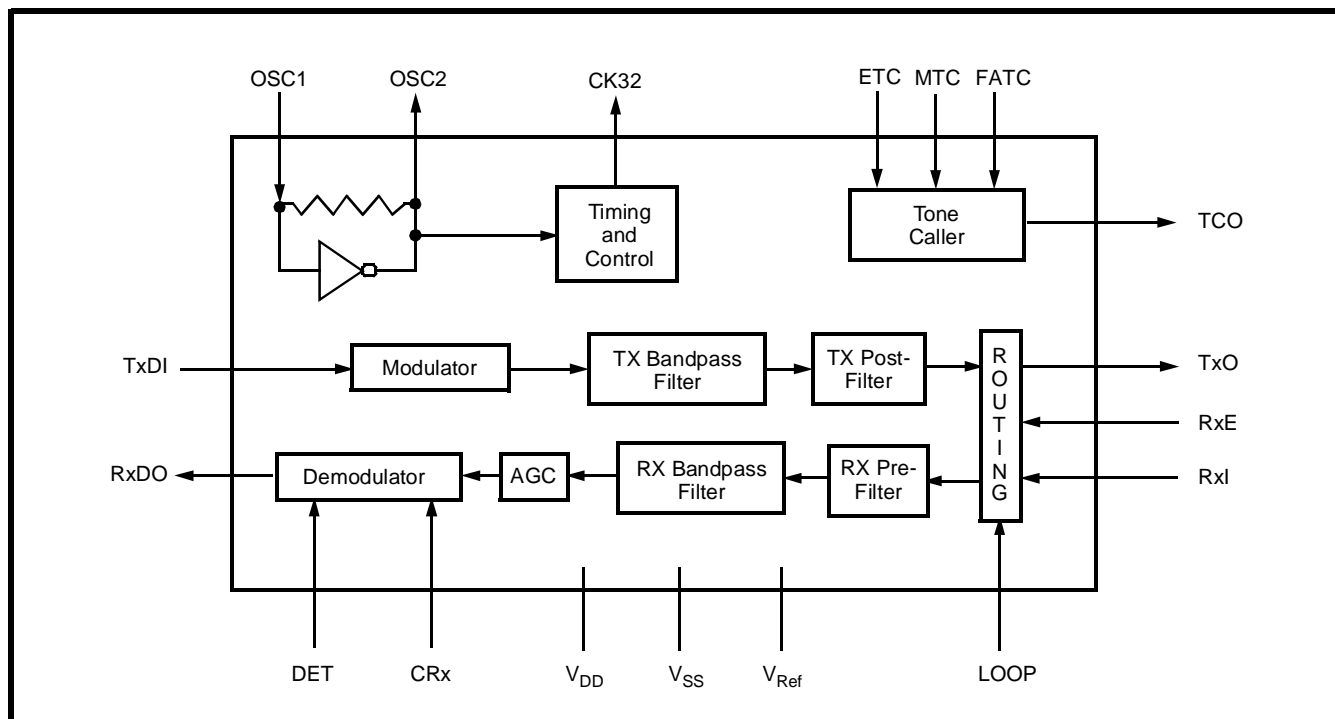


Figure 1 - Functional Block Diagram

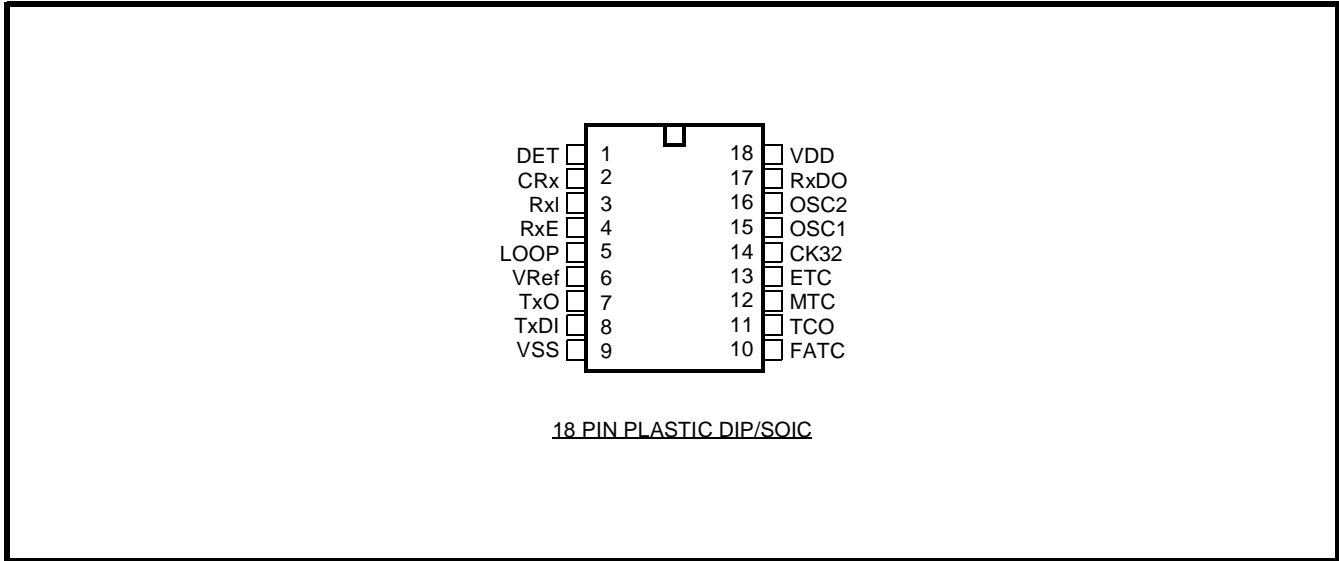


Figure 2 - Pin Connections

Pin Description

Pin #	Name	Description
1	DET	Demodulator detection level adjust input (Analog). Internal resistor divider applies 2.36V in open circuit condition. Connection of external resistor will vary detect level.
2	CRx	External AGC time constant adjust input (Analog). Connect external capacitor to V _{SS} .
3	RxI	Modulated receive signal input (Analog). Biased at V _{Ref} .
4	RxE	Receive enable input (Digital) with internal pull up. Active high.
5	LOOP	Self-test mode select input (Digital) with internal pull down. Active high.
6	V _{Ref}	Internal reference supply voltage input (Analog) .
7	TxO	Modulated transmit carrier output (Analog).
8	TxDI	Transmit data input (Digital).
9	V _{SS}	Negative power supply.
10	FATC	Tone caller center frequency adjust input (Analog).
11	TCO	Tone caller output (Digital).
12	MTC	Mute tone caller input (Digital) with internal pull down. Active high.
13	ETC	Enable tone caller input (Digital) with internal pull down. Active high.
14	CK32	32 kHz data strobe output (Digital).
15	OSC1	Clock Input
16	OSC2	Clock Output to drive external devices.
17	RxDO	Receive data output (Digital). Synchronized to CK32.
18	V _{DD}	Positive power supply.

Functional Description

The MT8840 contains the modulator and demodulator circuitry for 32 kHz ASK signalling as well as a two-tone warbler (tone caller) to replace the function of the mechanical telephone ringer.

A 32 kHz carrier is 100% amplitude modulated by the digital bit stream applied to input TxDI. This results in an amplitude shift keyed (ASK) 32 kHz carrier. A logical high at TxDI disables the carrier and a logical low enables it. The digitally modulated waveform is shaped by the Tx BANDPASS FILTER and smoothed by the Tx POST FILTER. The signal then enters the routing block where it is transferred to the TxO output.

The modulated 32 kHz receive signal is applied to RxI. With a logical low applied to LOOP and a logical high applied to RxE, receive signals are routed to the Rx PREFILTER. High frequencies are removed by the Rx PREFILTER to prevent aliasing in the switched capacitor Rx BANDPASS FILTER. Voice signals are removed by the bandpass filter which is followed by an AGC circuit. This provides a dynamic range of 20dB for the receiver. An external 1 μ F capacitor connected from CRx to V_{SS} is required to control the AGC attack and decay time constants. Data is recovered from the received signal in the demodulator. The minimum voltage level to which the demodulator responds may be adjusted by connecting a resistor from DET to V_{DD} or V_{Ref}. Since DET is the input to a comparator, noise should be kept to a minimum at this pin. The recovered receive data is synchronized to the leading edge of the 32 kHz clock (available at CK32) before appearing at RxDO.

When in loop around mode, the Rx PREFILTER input is internally disconnected from the RxI input pin and connected to TxO. The transmitter output is still available at TxO.

A two tone warbling audio signal is available at TCO when the tone caller enable input (ETC) is high. TCO is internally clamped to V_{Ref} when the tone caller is disabled. The tone output can be attenuated by 20dB if a logical high is applied to the tone caller mute input (MTC).

Applications

Figures 3 through 5 show how the MT8840 may be utilized to transfer data and voice simultaneously over a single pair of wires in digital or analog PABXs and "smart" telephone sets. In all three figures a microprocessor sends/receives data to/from the MT8840 via a UART which converts the data format from parallel-to-serial or serial-to-parallel for the transmit and receive directions, respectively. In the receive direction the MT8840 has on-board filters to reject voice-band signals leaving only the 32 kHz carrier. This carrier is then demodulated to recover the received data. In the transmit direction the data to be sent is modulated and passed on to a summing circuit which sums the modulated 32 kHz carrier and voiceband signals for transmission over the telephone line. In the PABX the Filter/Codec has filters which reject the 32 kHz carrier from the received composite voice and data signal allowing only voiceband signals to pass through which are then PCM encoded for digital switching. However, in both the analog PABX and smart telephone set, lowpass filters could be included to bandlimit the received signal leaving only voice signals to be passed on to the switch array or handset earpiece.

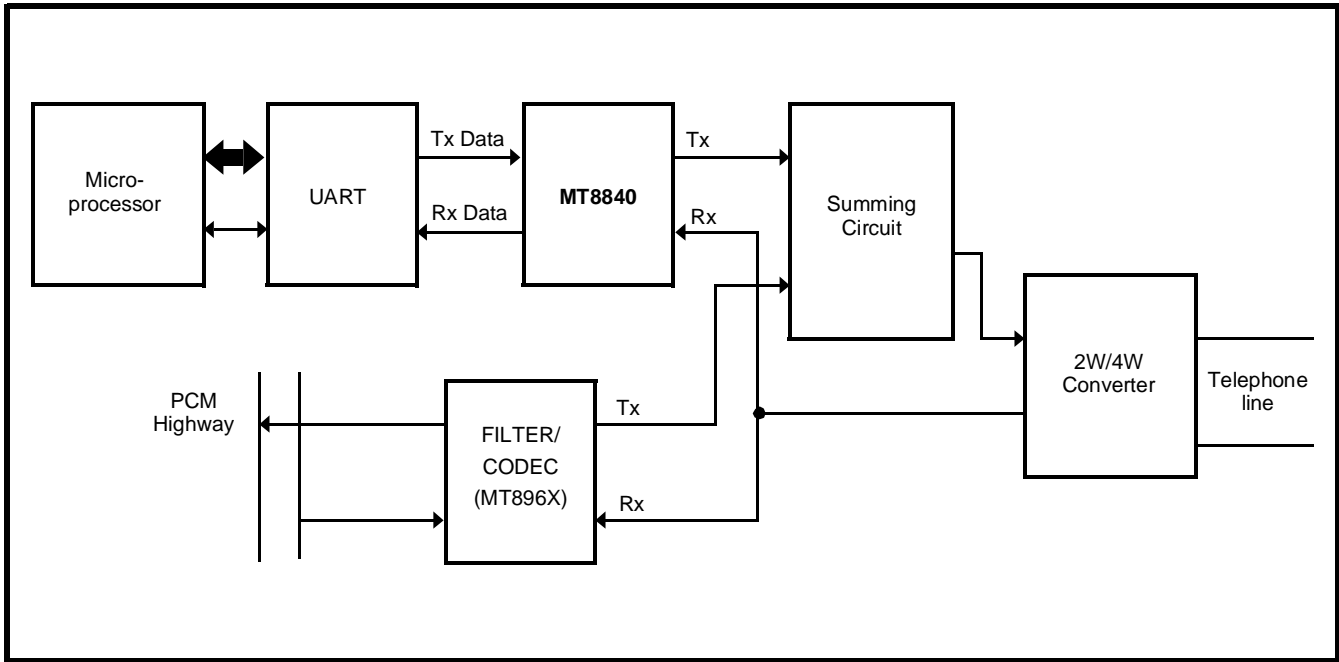


Figure 3 - Digital PABX Block Diagram

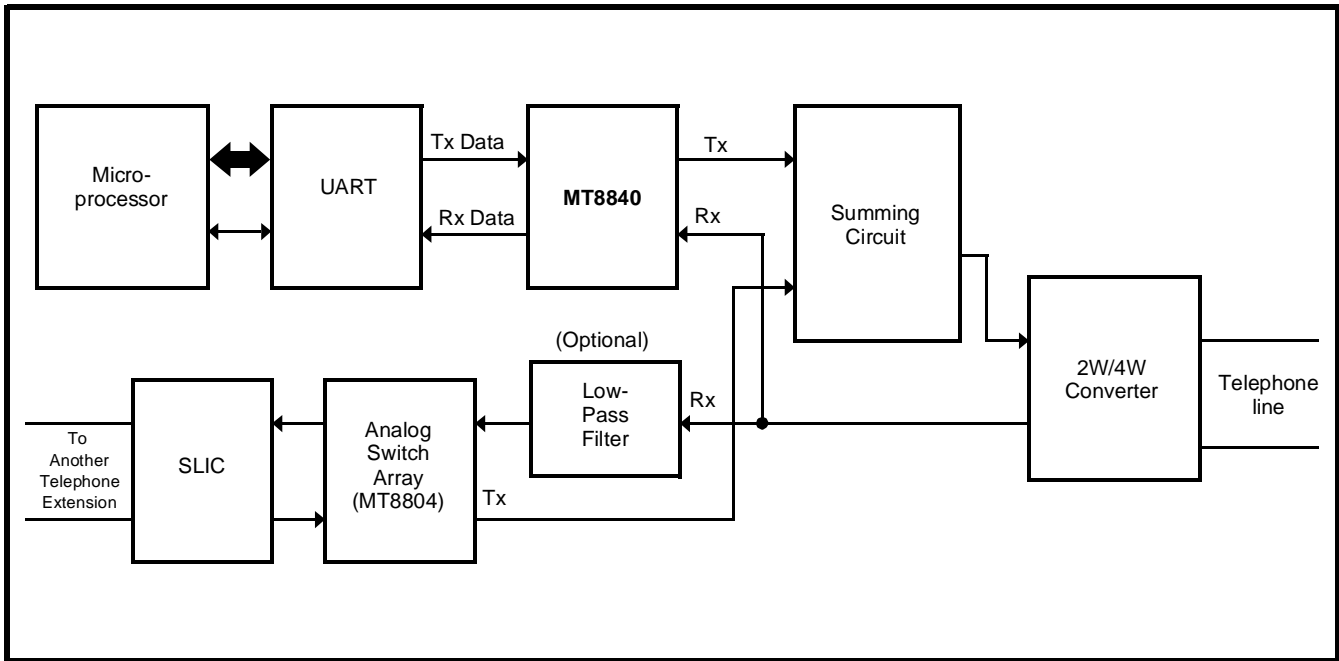


Figure 4 - Analog PABX Block Diagram

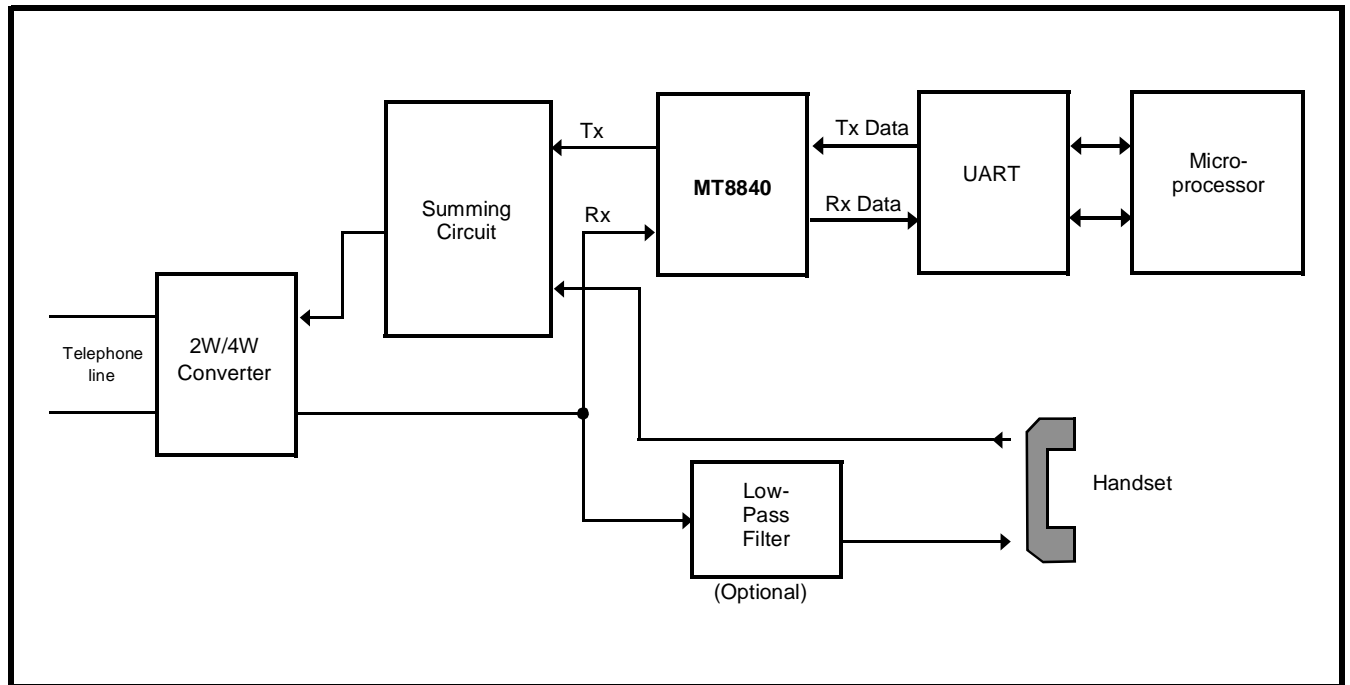


Figure 5 - Smart Telephone Set Block Diagram

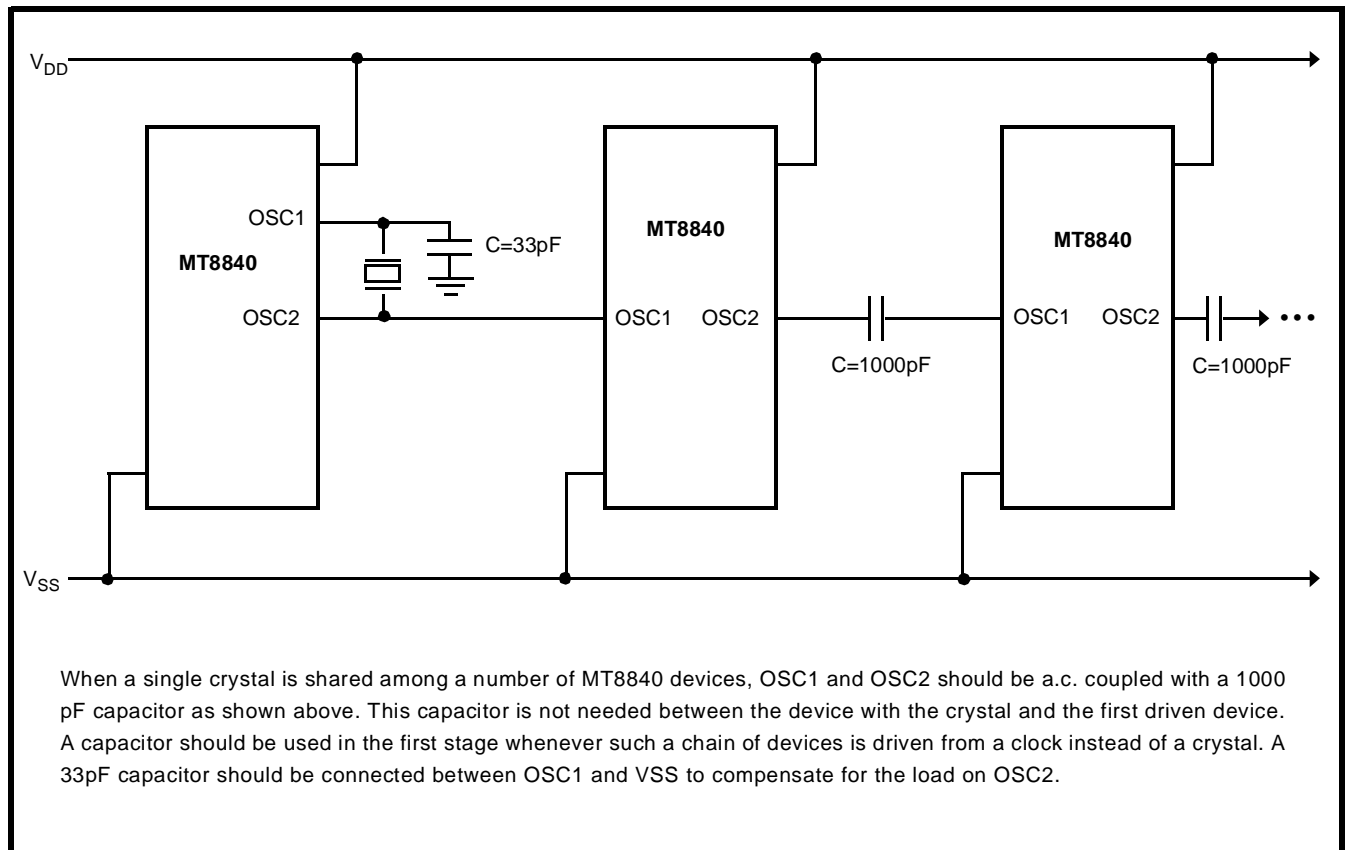


Figure 6 - Crystal Oscillator Connections for Driving Multiple MT8840s

Absolute Maximum Ratings*

	Parameter	Symbol	Min	Max	Unit
1	Supply Voltage	$V_{DD}-V_{SS}$	-0.3	+7.0	V
2	Voltage On Any Pin	V_{Max}	$V_{SS}-0.3$	$V_{DD}+0.3$	V
3	Current On Any Pin	I_{Max}		20	mA
4	Storage Temperature	T_S	-65	+150	°C
5	Package Power Dissipation	P_{Diss}		850	mW

* Exceeding these ratings may cause permanent damage. Functional operation under these conditions is not implied.

Recommended Operating Conditions

	Parameter	Symbol	Min	Typ	Max	Unit
1	Operating Supply Voltages	V_{DD}	4.75	5	5.25	V
2		V_{Ref}		$0.4V_{DD}$		V
3	Operating Supply Currents	I_{DD}		2.5	5.0	mA
4		I_{Ref}			200	μA
5	Operating Temperature	T_O	0		+85	°C
6	Load Capacitance (TxO)	C_L			50	pF
7	Load Resistance (TxO)	R_L	10			KΩ

D.C. Characteristics - $V_{DD} = 5.0\text{ V} \pm 5\%$ $V_{SS} = 0\text{V}$ $T = 0 - 85^\circ\text{C}$ (All voltages are referenced to V_{SS} /GND)

		Characteristics	Sym	Min	Typ	Max	Unit	Test Conditions
1	DIGITAL	Input Current	I_{IN}			±10	μA	$V_{IN} = 0$ to V_{DD}
2		Input Low Voltage	V_{IL}	0		1.5	V	
3		Input High Voltage	V_{IH}	3.5		5.0	V	
4		Output Low Voltage	V_{OL}			0.4	V	$I_{OL} = 0.4\text{mA}$
5		Output High Voltage	V_{OH}	4.6			V	$I_{OH} = 0.4\text{mA}$
6		Output Drive Current						
7		N Channel Sink (Except OSC2)	I_{OL}	0.4			mA	$V_{OL} = 0.4\text{V}$
8		OSC2		0.1			mA	
9		P Channel Source (Except OSC2)	I_{OH}	0.4			mA	$V_{OH} = 4.6\text{V}$
10		OSC2		0.1			mA	
11	ANALOG	Input Current (RxI, FATC)	I_{IN}			±10	μA	$V_{IN} = 0$ to 5.0V
12		Input Resistance (FATC)	R_{IN}	500			KΩ	
13		(DET to V_{DD})			170		KΩ	
14		(DET to V_{Ref})			23		KΩ	
15		Input Capacitance (RxI)	C_{IN}		50		pF	
16		(FATC)			10		pF	
17		Any Digital Input			5.0	7.5	pF	
18		Output Resistance (TxO)	R_O		100		Ω	
19		(TCO)			3		KΩ	MTC = 0
20		(TCO)			30		KΩ	MTC = 1
21		Output Offset Voltage (TxO)	V_O		±25	±200	mV	
22		Output Voltage (DET)	V_O	2.20	2.36	2.55	V	See Note 1

Notes: 1. Voltage specified is generated internally and measured with no external components connected to DET

A.C. Characteristics - $V_{DD}=5.0V\pm5\%$ $V_{SS}=0V$ $T=0 - 85^{\circ}C$ (All voltages are referenced to V_{SS}/GND)

		Characteristics	Sym	Min	Typ	Max	Unit	Test Conditions
1	DIGITAL	Crystal/Clock Frequency	f_C	3.5759	3.5795	3.5831	MHz	OSC1, OSC2
2		Clock Input (OSC 1)						
3		Rise Time	t_{LHCI}			100	ns	10% - 90% of ($V_{DD} - V_{SS}$)
4		Fall Time	t_{HLCI}			100	ns	
5		Duty Cycle	DC_{CI}	40	50	60	%	
6		Clock Output (OSC 2)						
7		Rise Time	t_{LHCO}		100		ns	$C_L = 30pF$, 3.58MHz ext. clock to OSC1
8		Fall Time	t_{HLCO}		100		ns	
9		Duty Cycle	DC_{CO}		50		%	
10		Capacitive Load	C_{LCO}			30	pF	
11		Clock Output (CK32)	F_{C32}	32508	32541	32574	Hz	$f_c = 3.5795MHz$
12		Rise Time	t_{LH32}		100		ns	10% - 90% of ($V_{DD} - V_{SS}$) $C_L = 100pF$
13		Fall Time	t_{HL32}		100		ns	
14		Duty Cycle	DC_{32}		50		%	
15		Capacitive Load	C_{L32}			100	pF	
16	TONE CALLER	Warbler Frequency (TCO)	f_W	7.935	7.945	7.955	Hz	$f_c = 3.5795MHz \pm 0.1\%$
17		Low Tone Frequency	f_{LT}	352	390	428	Hz	$FATC = 0$, $f_c = 3.5795MHz$
18				1036	1148	1260	Hz	$FATC = V_{DD}$, $f_c = 3.5795MHz$
19		High Tone Frequency	f_{HT}	440	487	535	Hz	$FATC = 0$, $f_c = 3.5795MHz$
20				1295	1434	1574	Hz	$FATC = V_{DD}$, $f_c = 3.5795MHz$
21		Harmonic Relationship	f_{HT}/f_{LT}		1.25			
22		Warbler Output (TCO)						
23		Rise Time	t_{LHWO}		500		ns	$100K\Omega$ load to V_{Ref} $C_L = 30pF$, $MTC = 0$
24		Fall Time	t_{HLWO}		500		ns	
25		Duty Cycle	DC_{WO}		50		%	
26		Output Level (TCO)	V_{TCC}		V_{DD}		V_{pp}	$MTC = 0$
27					0.625		V_{pp}	$MTC = 1$ ($100K\Omega$ load to V_{Ref})
28	MODULATOR	Modulated Frequency	f_{MOD}		32541		Hz	
29		Output Level (TxO)	V_{TxO}	225	250	270	mV_{pp}	$V_{DD} = 5V$
30		Output Level (TxO) variation vs. V_{DD}	V_{TxO}		100		%	
31								
32		Transmit Data Input (TxDI)						
33		Rise Time	t_{LHTxDI}			100	ns	
34		Fall Time	t_{HLTxDI}			100	ns	
35		Data Rate (TxDI)	f_{Data}		2		k/bits	See Note 1
36	DEMODULATOR	Input Impedance (RxI)	Z_{IN}		50		$K\Omega$	32 kHz Input Frequency
37		Valid Input Level - Data (RxI)	V_{RxI}	40		400	mV_{pp}	See Note 2
38		Valid Input Level - Data + Voice	V_{RxI}			3.0	V_{pp}	
39		Receive Data Output (RxDO)	f_{Data}		2		kbit/s	
40		Rise Time			100		ns	10% - 90% of ($V_{DD} - V_{SS}$) $C_L = 100pF$
41		Fall Time			100		ns	
42		Capacitive Load				100	pF	
43		Duty Cycle		40	50	60	%	

Notes: 1. All A.C. parameters are based on a typical data rate of 2 kbit/s.
2. Measured with no external resistor to DET input. Detection level internally set to 2.36V typical.

A.C. Characteristics (Continued)

		Characteristics	Sym	Min	Typ	Max	Unit	Test Conditions
44	D	Inband Noise Rejection (S/N)		12			dB	Input Sig. (RxI) = 400mV _{pp}
45	E	Attenuation to Voice Signals		40			dB	f _{in} = 0 - 5KHz
46	M	Detect Filter Q	Q		3.8			
47	O	Detector Center Frequency			32		kHz	

Notes: 1. All A.C. parameters are based on a typical data rate of 2 kbit/s.
 2. Measured with no external resistor to DET input. Detection level internally set to 2.36V typical.